


<b>Search Notes</b>  	<b>Application/Control No.</b>  10590726	<b>Applicant(s)/Patent Under Reexamination</b>  NAKADA ET AL.
	<b>Examiner</b>  Tianjie Chen	<b>Art Unit</b>  2627

SEARCHED			
Class	Subclass	Date	Examiner
720	651		
	601		
	603		
	611		
369	44.32	3/12/2008	TJ

SEARCH NOTES		
Search Notes	Date	Examiner
East Report	3/12/2008	TJ

INTERFERENCE SEARCH			
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720	651	3/12/2008	TJ